# SPECTRAL TECHNIQUES FOR OFF-LINE TESTING AND DIAGNOSIS OF COMPUTER SYSTEMS* 

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#### Abstract

In this paper we present some of our recent results on applications of spectral techniques over finite fields to the problems of testing and diagnosis of computer systems.


## 1. Testing By Space Compression Of Test Responses

Consider a computer system of (not necessarily identical) processing elements (PEs) (this system may be a computer board, multichip module, array processor or computer network). If the system has $n$ output PEs and every PE has at most $m$ output pins, then the response of the system at any given time can be represented as $y=\left(y_{0}, \ldots, y_{n-1}\right)$, where $y_{i} \in Z_{q}, q=2^{m}, Z_{q}$ is the field with $q=2^{m}$ elements and $y \in Z_{q}^{n}$.

Let $E \subseteq Z_{q}^{n}$ be the set of all possible errors in the system such that as a result of the error $e \in E y$ is replaced by $y+e$.

Problems of compression of test responses for error detection can be formulated in the following way:

P1. Given $E \subseteq Z_{q}^{n}$, construct a transform $y \longmapsto H(y)$,

$$
H(y)=\left\{H_{j}(y) \mid j=0,1, \ldots, r-1\right\}, \quad H_{j}(y) \in Z_{q},
$$

with minimal $r$ such that

$$
H(y+e) \neq H(y) \text { for all } y \in Z_{q}^{n} \text { and } e \in E .
$$

P2. Given a distribution $P(E)=\left\{P_{0}, P_{1}, \ldots, P_{M-1}\right\}$, where $M=q^{n}$ and $P_{i}=\operatorname{Prob}\{e=i\}$, construct a transform $y \longmapsto H(y)$,

$$
H(y)=\left\{H_{j}(y) \mid j=0,1, \ldots, r-1\right\}, \quad H_{j}(y) \in Z_{q},
$$

minimizing $\operatorname{Prob}\{H(y+e)=H(y)\}$ (we assume that all $y \in Z_{q}^{n}$ are uniformly distributed).

[^0]We note that $Z=H(y) \in Z_{q}^{r}\left(Z=\left(Z_{0}, \ldots, Z_{r-1}\right),\left(Z_{j}=H_{j}(y), Z_{j} \in Z_{q}\right)\right)$, and if $r \ll n$ by monitoring $Z \in Z_{q}^{r}$ instead of $y \in Z_{q}^{n}$ one can achieve a considerable reduction in overheads required for testing.

Let us consider the case $r=1$. Select

$$
\begin{equation*}
Z=Z_{1}=H_{1}\left(y_{0}, y_{1}, \ldots y_{n-1}\right)=\sum_{i=0}^{n-1} y_{i} \alpha^{i}, \tag{1}
\end{equation*}
$$

where $\alpha$ is a primitive element in $Z_{q}$, and all the operations in (1) are in $Z_{\boldsymbol{q}}(n \leq q-1)$. This approach is known as the signature analysis and is widcly used for off-line testing and for built-in self testing (BIST) [1, 2].

Computation of the signature, $Z$, can be implemented in $n$ steps by the following recursive procedure:

$$
\begin{equation*}
Z^{(i-1)}=\alpha Z^{(i)}+y_{i-1} \quad(i=n, n-1, n-2, \ldots, 1) \tag{2}
\end{equation*}
$$

where

$$
Z^{n}=0, Z^{(i)} \in Z_{q} \text { and } Z^{(0)}=Z
$$

This procedure can be implemented in hardware by an $m$-bit linear feedback shift register (LFSR) with parallel input and with the characteristic equation defined by (2) where $y_{i-1}$ is the new input, $Z^{(i)}$ is the previous state and $Z^{(i-1)}$ is the new state.

The hardware implementation of an $m$-bit LFSR requires only $m$ flip-flops and several XOR gates in the feedback loops [1].

We note that $Z_{1}$ defined by (1) is the first coefficient of the Fourier expansion of $y=\left(y_{0}, y_{1}, \ldots, y_{n-1}\right)$ over $Z_{q}[3,4]$. The network (LFSR) computing $Z_{1}$ can be considered as a network computing syndrome for the $q$-ary $(n, n-1)$ Reed Solomon code of length $n$ with distance 2 [5]. In view of this one can see that (1) provides for the solution of $\mathbf{P} 1$ for single errors, i.e. when $E=\{e\|e\|=1\}$, where $\|e\|$ is the number of nonzero components in $e=\left(e_{0}, e_{1}, \ldots, e_{n-1}\right)\left(e_{i} \in Z_{q}\right)$.

Let us consider the efficiency of the signature analysis defined by (1) for solution of P2. In this case we assume that errors in different components of $y$ are independent (components of $e$ are independent), and all components of $e$ have the same distribution

$$
\begin{gathered}
P(e)=\left(P_{0}, P_{1}, \ldots, P_{q-1}\right) \\
\left(q=2^{m}, P_{i}=\operatorname{Prob}\left\{e_{j}=i \mid \text { for all } j=0,1, \ldots, n-1\right\}\right)
\end{gathered}
$$

We will present below our results on probabilities $P_{A L}=\operatorname{Prob}\left\{H_{1}(y+e)=H_{1}(y)\right\}$ (which are also known as masking or aliasing probabilities) for three important classes of error distributions which correspond to so called "symmetrical errors", "independent errors", and "errors of a given multiplicity".

For symmetrical errors we assume $[6,7,8]$ :

$$
P_{i}=\left\{\begin{array}{ll}
1-p, & i=0 ;  \tag{3}\\
p\left(2^{m}-1^{-1},\right. & i \neq 0
\end{array} \text { for some } 0<p<1\right.
$$

In this case using results from $[6,10]$ it is possible to show that

$$
\begin{align*}
P_{A L} & =\operatorname{Prob}\{H(y+e)=H(y)\} \\
& =2^{-m}\left[1-2^{m}(1-p)^{n}+\left(2^{m}-1\right)\left(1-2^{m} p\left(2^{m}-1\right)^{-1}\right)\right. \tag{4}
\end{align*}
$$

For independent errors $[6,7,9]$ we consider every $e_{j} \in Z_{q}\left(q=2^{m}\right)$ as an $m$-bit binary vector, and we assume that distortions in the binary components of these vectors are independent. If $\|i\|$ is the number ones in the binary representation of $i\left(i=0,1, \ldots 2^{m}-1\right)$, then we have for independent errors

$$
\begin{equation*}
P_{i}=\binom{m}{\|i\|} p_{b}^{\|i\|}\left(1-p_{b}\right)^{m-\|i\|} \tag{5}
\end{equation*}
$$

where $p_{b}$ is a probability of a distortion of one bit, and for $n=c\left(2^{m}-1\right)$ we have $[6,7]$

$$
\begin{equation*}
P_{A L}=2^{-m}\left[1-\left(2^{m}-1\right)\left(1-2 p_{b}\right)^{c m 2^{m-1}}\right]-\left(1-p_{b}\right)^{c\left(2^{m}-1\right) m} \tag{6}
\end{equation*}
$$

For errors of a given magnitude [6]

$$
P_{i}=\left\{\begin{array}{ll}
1-p, & i=0 ;  \tag{7}\\
p, & i=a \\
0, & \text { otherwise }
\end{array} \quad \text { for some } a \in Z_{q}-0\right.
$$

and for $n=2^{m}-1$

$$
\begin{equation*}
P_{A L}=2^{-m}\left[1-\left(2^{m}-1\right)(1-2 p)^{2^{m-1}}\right]-(1-p)^{2^{m}-1} \tag{8}
\end{equation*}
$$

For large $n$, (say, $n>50$ ) for all three models $P_{A L}=2^{-m}$. Analysis of aliasing probabilities for benchmark circuits [6] shows that for small $n$ the independent error model predicts minimum aliasing, and the symmetrical model predicts aliasing more accurately than the other models.

Let us consider now the case $r>1$. In this case we select the following system of $r q$-ary functions

$$
\begin{equation*}
Z_{j}=H_{j}\left(y_{0}, \ldots, y_{n-1}\right)=\sum_{i=0}^{n-1} y_{i} \alpha^{j i}, \quad(j=0, \ldots, r-1) \tag{9}
\end{equation*}
$$

where $\alpha$ is a primitive in $Z_{q}, q=2^{m}$. This approach is known as the multisignature analysis, and it was also used for off-line testing and diagnosis [11, 12, 13]. The hardware implementation of this approach requires $r m$-bit LFSRs with characteristic equations

$$
\begin{equation*}
Z^{(i-1)}=\alpha^{j} Z^{(i)}+y_{i-1}, \quad Z^{(n)}=0, \quad Z^{(0)}=Z_{j}, \quad j=0,1, \ldots, r-1 \tag{10}
\end{equation*}
$$

In this case $Z_{0}, Z_{1}, \ldots, Z_{r-1}$ defined by (9) are the first $r$ coefficients of the Fourier expansion of $y=\left(y_{0}, y_{1}, \ldots, y_{n-1}\right)$ over $Z_{q}$. The network computing $Z_{0}, Z_{1}, \ldots, Z_{r-1}$
( $r m$--bit LFSRs ) computes syndromes for the $q$-ary ( $n, n-r$ ) Reed-Solomon codes of length $n$ with distance $r+1$. Thus, (9) provides for the minimal solution of P1 for the case when at most $r$ components of $e=\left(e_{0}, e_{1}, \ldots, e_{n-1}\right)$ are not equal to 0 , i.e. at most $r$ components of $y=\left(y_{0}, \ldots, y_{n-1}\right)$ are distorted $(E=\{e \mid 0<\|e\| \leq r\})$. For large $n$ we have for the above error models $P_{A L} \longmapsto 2^{-m}=q^{-r}$ for all $e$ such that $\|e\|>r$. $\left(P_{A L}=0\right.$ for $\left.0<\|e\| \leq r\right)$.

Let us consider a more general case when the set, $E$, of errors is defined by the topology of the system. Let $X$ be the set $\left\{X_{0}, X_{1}, \ldots, X_{N-1}\right\}$ of $N$ processing elements. Consider a digraph $G$ having $X$ as a set of vertices and a set $U=$ $\left\{U_{0}, U_{1}, \ldots, U_{M-1}\right\}$ of directed edges ( $m$-bit communication links) between vertices of $G$. We shall also assume that the graph has no cycles and all $n$ output vertices are reachable from at least one input vertex. Let $y=\left(y_{0}, y_{1}, \ldots, y_{n-1}\right) \in Z_{q}^{n}$ be an output vector for the system represented by the graph $G$, where $y_{i} \in Z_{q}$ is an output of the corresponding output vertex ( $i=0,1, \ldots, n-1$ ). The problem to be considered is the problem of error detection under the assumption of single vertex failures in the graph $G$. A failure in the graph (system of processing elements) refers to a physical malfunction that cause an undesired event. We consider a fault in the graph which alter its output value to $\tilde{y}=\left(\tilde{y}_{0}, \tilde{y}_{1}, \ldots, \widetilde{y}_{n-1}\right)$, where $\widetilde{y}_{i} \in Z_{q}$. The error in the graph's output $y$ can be characterized by the error vector $e=\left(e_{0}, e_{1}, \ldots, e_{n-1}\right)$ where $e_{i}=\tilde{y}_{i}+y_{i}$ for $i=0,1, \ldots, n-1$.

Let us define an error set $E(G)$ characterized by the underlying graph $G$. In our definition of an error set we assume that at most one vertex or any number of incoming edges to this vertex may fail and a fault in the graph manifests itself by distorting all successor vertices' outputs, i.e. error propagates along a directed path. Let $E_{j}=\left\{\left(e_{0}^{(j)}, e_{1}^{(j)}, \ldots, e_{n}^{(j)}\right)\right\}(j=0, \ldots, N-1)$ be a set of error patterns corresponding to a fault in vertex $X_{j}$, where $e_{i}^{(j)} \in Z_{q}-0$, if there exists a directed path from $X_{j}$ to an output and $e_{i}^{(j)}=0$ otherwise. The set $E(G)=\cup_{j=0}^{N-1} E_{j}$ of all possible error patterns corresponding to all single vertex failures in $G$ called the error set for $G$. To illustrate the above definition let us now consider the $p$-ary star network topology (see Fig. ). For this $p$-ary star, the single central processing element (root) is connected to all others, $N=p+1$ and $n=p$. Due to single vertex of processing element failures we have the following nonzero errors in the $p$-ary star:

$$
E(G)=\left\{\begin{array}{c}
\left(e_{0}, e_{1}, \ldots, e_{p-1},\right.  \tag{11}\\
\left(e_{0}, 0,0,0, \ldots, 0\right) \\
\left(0, e_{1}, 0,0, \ldots, 0\right) \\
\vdots \\
\left(0,0, e_{2}, 0, \ldots, 0\right)
\end{array}\right\}
$$

where $e_{i} \in Z_{q}-0$. Thus, we have $|E(G)|=(q-1)^{p}+p(q-1)$ nonzero error vectors for $p$-ary star over $Z_{q}$.

Let $Z=H y$, where $H$ is a $(r \times n) q$-ary transform matrix over $Z_{q}\left(y \in Z_{q}^{n}, Z \in\right.$ $\left.Z_{q}^{r}\right)$. Consider a graph, $G(E)$, having the error set $E(G)(0 \notin E(G))$ as a set of vertices and $U=\left\{\left(E_{i}, E_{j}\right) \mid E_{i}, E_{j} \in E(G), E_{i}+E_{j} \in E(G)\right\}$ as a set of edges.


Figure 1: p-ary Star Network Topology


Figure 2: 4-ary Full Tree of Height $\mathrm{b}=3$

Denote by $\chi(E)$ the chromatic number for $G(E) .(\chi(E)$ is a minimal number of colors required to color the vertices of $G(E)$ in such a way that no two neighboring vertices have the same color. Techniques for graph coloring with lower and upper bounds for $\chi(E)$ can be found e.g. in [14]). Then using results from [14, 15] we have for a minimal number $r_{\text {min }}$ of transform coefficients required for detection of $E(G)$ :

$$
\begin{equation*}
\min \left(\eta_{1}, \eta_{2}\right) \leq r_{\min } \leq\left\lceil\log _{q}(|E(G)|(q-1)+1)\right\rceil \tag{12}
\end{equation*}
$$

where $\eta_{1}=n-\left\lfloor\log _{q}\left(q^{n}-|E(G)|\right)\right\rfloor$, and $\eta_{2}=\left\lceil\log _{q}(\chi(E)+1)\right\rceil$.
We will present now solutions for the data compression problem P1 for the two important topologies: trees and Fast Fourier Transform (FFT) networks.

Let $T_{h}$ be a $p$-ary full tree of height $h(p \geq 2, h \geq 2)$. The height of the tree is the length of a longest path from the root to any leaf. (Here we assume that input vertex is the root and the output vertices are $n=p^{h-1}$ leaves of the tree). Then

$$
\begin{equation*}
|E(G)|=\sum_{i=0}^{h-1} p^{i}(q-1)^{p^{h-1-i}} \tag{13}
\end{equation*}
$$

For example, 4-ary tree $T_{3}$ is represented in Fig.
For this tree the error set $E(G)$ is:
where $e_{i} \in Z_{q}-0$. It is possible to show ( $[15,16]$ ), that for a p-ary full tree with $h \leq\left(\log _{p}\left(1+(q-1)^{-1}\right)\right)$ for any $p, r_{\min }=h$ and

$$
H=H^{(h)}=[\overbrace{H^{(h-1)} H^{(h-1)} H^{(h-1)} \ldots H^{(h-1)}}^{p}]
$$

where $W$ is a row of one 1 followed by $n-1=p^{h}-1$ zeros, and

$$
H^{(2)}=\left[\begin{array}{llllll}
1 & 1 & 1 & 1 & \ldots & 1  \tag{15}\\
1 & 0 & 0 & 0 & \ldots & 0
\end{array}\right]
$$

For example, for $T_{3}$ represented by Fig. $(p=4, h=3)$ we have

$$
H=H^{(3)}=\left[\begin{array}{lllll}
1111 & 1111 & 1111 & 1111 \\
1000 & 1000 & 1000 & 1000 \\
1000 & 0000 & 0000 & 0000
\end{array}\right]
$$

For the n-point FFT, there are $N=n \log _{2} n$ vertices interconnected with $\log _{2} n$ levels of butterfly structures, e.g., the graph for the 8 -point FFT with decimation-in-frequency (DIF) is shown in Fig..

If we include input fanout branches as possible source of errors, then there are $n\left(\log _{2} n+1\right)$ single faults in the $n$-point FFT graph. Due to these single faults we have the following nonzero errors for the 8 -point FFT graph of Fig. :
where $e_{i} \in Z_{q}-0$ and $|E(G)|=\sum_{i=0}^{t} 2^{i}(q-1)^{2^{t-i}}, n=2^{t}$.
The recursive construction for matrices $H$ for DIF FFT topologies is given by

$$
H=H^{(n)}=\left[\begin{array}{c}
H^{(n / 2)} H^{(n / 2)}  \tag{16}\\
W
\end{array}\right] \quad W=[100 \ldots 0] \quad H^{(2)}=\left[\begin{array}{l}
11 \\
10
\end{array}\right]
$$

For example, for the 8-point DIF FFT graph represented by Fig. :

$$
H=H^{(8)}=\left[\begin{array}{lllll}
11 & 11 & 11 & 11 \\
10 & 10 & 10 & 10 \\
10 & 00 & 10 & 00 \\
10 & 00 & 00 & 00
\end{array}\right] .
$$

(A construction similar to (16) can be used for FFTs with decimation-in-time [16]).
Thus for a $n$-point FFT we have

$$
\begin{equation*}
r_{\min }=\log _{2} n+1 \tag{17}
\end{equation*}
$$

The flow graph of the Walsh-Hadamrd Transform (WHT) [3, 4] differs from the flow graphs of the FFT only in the values of twiddle factors ( $\pm 1$ for WHT ). Thus, solution (16) is valid also for networks computing WHTT. Solutions for multidimensional FF'Ts and for Fast Chrestenson Transforms can be found in [16].

To conclude this section we note that elements of matrices $H$ for trees and FFTs are zeros and ones only.

## 2. Robust Quadratic Transforms for Testing of Computer Systems.

In the previous section we considered linear data compressors $Z=H y,\left(Z \in Z_{q}^{r}\right.$, $y \in Z_{q}^{n}$ ). For any linear transform we have for the probability, $P_{A L}(e)$, of masking (aliasing probability) for a given error pattern $e$

$$
P_{A L}(e)=\operatorname{Prob}\{H(y+e)=H(y)\}=\operatorname{Prob}\{H e=0\}= \begin{cases}1, & e \in \operatorname{Kern} H ;  \tag{18}\\ 0, e \notin \operatorname{Kern} . H\end{cases}
$$

Thus, performances of linear compressors are very sensitive to error distributions

$$
P=\left\{P_{0}, P_{1}, \ldots, P_{M-1}\right\}\left(M=q^{n}, P_{i}=\operatorname{Prob}\{e=i\}\right)
$$

We will describe in this section a class of nonlinear quadratic robust transforms, such that their performances do not depend on error distributions. We will show that for optimal robust transforms described by $r$ quadratic $q$-ary functions, we have

$$
P_{A L}(e)=q^{-r} \quad \text { for any } e \neq 0
$$

Suppose $n=2 r s$. Consider the following nonlinear mapping $Z_{q}^{n} \longmapsto Z_{q}^{r}$

$$
\begin{equation*}
Z=\left(Z_{0}, \ldots, Z_{r-1}\right)-H\left(y_{0}, \ldots, y_{n-1}\right)=Y_{0} Y_{1}+Y_{2} Y_{3}+\ldots+Y_{2 s-2} Y_{2 s-1} \tag{19}
\end{equation*}
$$



Figure 3: Eight-Point DIF FFT Network Topology
where $Y_{i}=\left(y_{i r}, \ldots, y_{(i+1) r-1}\right)(i=0, \ldots, 2 s-1)$, and all operations in the quadratic form (19) are in $Z_{q}^{r}$.

For $q=2$ and $r=1$ these quadratic forms are known as bent functions [3, 5,18 , $19,20,21]$. In this case $n=2 s, Y_{i}=y_{i}$ and

$$
\begin{equation*}
Z=y_{0} y_{1}+y_{2} y_{3}+\ldots+y_{n-2} y_{n-1} \tag{20}
\end{equation*}
$$

and we have for the autocorrelation for bent functions

$$
B(e)=\sum_{y \in Z_{2}^{n}} H(y) H(y+e)=\left\{\begin{array}{l}
2^{n-1}-2^{n / 2-1}, e=0  \tag{21}\\
2^{n-2}-2^{n / 2-1}, e \neq 0
\end{array}\right.
$$

Thus $B(e)=$ Const $_{e \neq 0}$. (We note that $B(e)$ can be computed by applying twice the Walsh-Hadamard Transform using the Wiener-Khinchin theorem [3].)

For any linear function $f\left(y_{0}, \ldots, y_{n-1}\right) .\left(y_{i} \in Z_{2}\right)$ such that

$$
f\left(y_{0}, \ldots, y_{n-1}\right)=\left\{\begin{array}{l}
1,\left(y_{0}, \ldots, y_{n-1}\right) \in V \\
0,\left(y_{0}, \ldots, y_{n-1}\right) \notin V
\end{array}\right.
$$

where $V$ is a subspace of $Z_{2}^{n}$, we have for its autocorrelation

$$
B(e)=\sum_{y \in Z_{2}^{n}} f(y) f(y+e)=\left\{\begin{array}{c}
|V|, e \in V  \tag{22}\\
0, \\
e \notin V
\end{array}\right.
$$

Since for bent functions defined by (20), we have $B(e)=$ Const $_{e \neq 0}$, one can say that bent functions are at the maximal distance from any linear function [5].

Let us introduce a system of characteristic functions $h_{i}(y)\left(i=0, \ldots, q^{r}-1\right)$ for non-repeatative quadratic form $H$ over $Z_{q}^{\tau}$ defined by (19):

$$
\begin{equation*}
h_{i}(y)=1 \text { iff } H(y)=i . \tag{23}
\end{equation*}
$$

Autocorrelation functions $B_{i}(e)$ for $h_{i}(y)$ can be defined as

$$
\begin{equation*}
B_{i}(e)=\sum_{y \in Z_{q}^{n}} h_{i}(y) h_{i}(y+e)=|\{y \mid H(y)=H(y+e)=i\}| . \tag{24}
\end{equation*}
$$

(Autocorrelation functions $B_{i}(e)$ can be computed by the Wiener-Khinchin theorem using the Chrestenson transform over $Z_{q}^{r}[3,4]$.)

It is possible to show $[22,23]$ that for $i \neq 0$

$$
B_{i}(e)=\left\{\begin{array}{l}
q^{2 r s-r}-q^{r s-r}, e=0  \tag{25}\\
q^{2 r s-r} \pm q^{r s-r}, e \neq 0
\end{array}\right.
$$

and we have for the total autocorrelation

$$
B(e)=\sum_{i} B_{i}(e)=|\{y \mid H(y)=H(y+e)\}|=\left\{\begin{array}{cc}
q^{2 r s}, & e=0  \tag{26}\\
q^{2 r s-r}, & e \neq 0
\end{array}\right.
$$

where $H(y)$ is defined by (19).
Thus, quadratic forms defined by (19) have the flat total autocorrelation and compressors implementing these forms are robust with a probability of masking any error

$$
\begin{equation*}
P_{A L}(e)=q^{-r}=2^{-m r} . \tag{27}
\end{equation*}
$$

Let $C$ be a quadratic $q$-ary error-detecting code defined as $y \in C$ iff

$$
\begin{equation*}
H(y)=Y_{0} Y_{1}+\ldots+Y_{2 s-2} Y_{2 s-1}=1 \tag{28}
\end{equation*}
$$

where $Y_{i}=\left(y_{i r}, \ldots, y_{(i+1) r-1}\right)$ and all operations in (28) are in $Z_{q}^{r}$. Then $C$ is a code with the length $n=2 r s$ and the number of codewords $|C|=q^{2 s r-r}-q^{s r-r}$. These codes provide for an equal protection against all possible errors for large $q$ or large $n$ and are optimal for the minimax criterion on error detection [22]. For a given block size, $n$, and the number of codewords, $|C|$, these codes minimize $\max _{e \neq 0} Q(e)$ where $Q(e)$ is the conditional error masking probability given the error pattern $e$. For these codes for any $e \neq 0$

$$
\begin{equation*}
\frac{\left(q^{2 r s-2 r}-q^{r s-r}\right)}{\left(q^{2 r s-r}-q^{r s-r}\right)} \leq Q(e) \leq \frac{\left(q^{2 r s-2 r}+q^{r s-r}\right)}{\left(q^{2 r s-r}+q^{r s-r}\right)} \tag{29}
\end{equation*}
$$

and

$$
\begin{equation*}
Q(e) \sim q^{-r} \tag{30}
\end{equation*}
$$

for large $n$ or large $q$. Simple encoding and decoding procedures for these codes are presented in [22].

## 3. Soft Decision Diagnosis.

Let $y=\left(y_{0}, y_{1}, \ldots, y_{n-1}\right), y_{i} \in Z_{q}, q=2^{m}$ be a test response for a system-under-test. As a result of faults in the system $y$ may be distorted into $y+e$, where $e=\left(e_{0}, e_{1}, \ldots, e_{n-1}\right), e_{i} \in Z_{q}, e \in E(G)$, and the set of errors, $E(G)$, is defined by the topology of the system. Denote

$$
\operatorname{supp}(e)=\left(\operatorname{supp}\left(e_{0}\right), \ldots, \operatorname{supp}\left(e_{n-1}\right)\right)
$$

where

$$
\operatorname{supp}\left(e_{i}\right)= \begin{cases}1, & e_{i} \neq 0 \\ 0, & e_{i}=0\end{cases}
$$

The soft decision diagnosis problem can be formulated in the following way. For a given $E(G) \subseteq Z_{q}^{n}$ construct a transform $Z=H(y)$ over $Z_{q}$

$$
\begin{equation*}
Z_{j}=H_{j}\left(y_{0}, \ldots, y_{n-1}\right)(j=0,1, \ldots, r-1) \tag{31}
\end{equation*}
$$

with minimal $r$ such that

$$
\begin{equation*}
H\left(y+e^{(1)}\right) \neq H\left(y+e^{(2)}\right) \tag{32}
\end{equation*}
$$

for any $e^{(1)}, e^{(2)} \in E(G)$ and $\operatorname{supp}\left(e^{(1)}\right) \neq \operatorname{supp}\left(e^{(2)}\right)$. We will consider the case when $H$ is linear. Then (32) can be written as:

$$
\begin{equation*}
H e^{(1)} \neq H e^{(2)} \tag{33}
\end{equation*}
$$

for any $e^{(1)}, e^{(2)} \in E(G), \operatorname{supp}\left(e^{(1)}\right) \neq \operatorname{supp}\left(e^{(2)}\right)$ and all operations are in $Z_{q}$. We will call $H(y)$ a fault-free signature, $H(y+e)$ a faulty signature and $S=H e$ a syndrome of error $e$. If (33) is satisfied, then the location, $\operatorname{supp}(e)$, of an error $e$ can be computed by analysis of the distortion $H(y)+H(y+e)$ in the fault-free signature. The bounds on a minimal number of spectral coefficients in the transforms satisfying (33) can be obtained from bound (12) for error detection by replacing the error set $E(G)$ with $E(G) \cup\left\{e^{(1)}+e^{(2)} \mid \operatorname{supp}\left(e^{(1)}\right) \neq \operatorname{supp}\left(e^{(2)}\right) ; e^{(1)}, e^{(2)} \in E^{\prime}(G)\right\}$. We note that any matrix $H$ satisfying (33) is a parity check matrix of a linear $q$-ary ( $n, n-r$ ) code locating the error set $E(G)$. We note also that a linear $(n, n-r)$ code with a parity check matrix $H$ locating an error set $E(G), 0 \notin E(G)$ corrects $E(G)$ if and only if for every distinct $e^{(1)}, e^{(2)} \in E(G)$ with $\operatorname{supp}\left(e^{(1)}\right)=\operatorname{supp}\left(e^{(2)}\right)$, there exists a pair $e^{(3)}, e^{(4)} \in E(G) \cup 0$ with $\operatorname{supp}\left(e^{(3)}\right) \neq \operatorname{supp}\left(e^{(4)}\right)$ such that $e^{(1)}+e^{(2)}=e^{(3)}+e^{(4)}$.

We note that the above condition is a necessary and sufficient condition on the set $E(G)$ such that if and only if this condition is satisfied any linear code locating
$E(G)$ will also correct $E(G)$. For example, for the $p$-ary star with $p=5$ and $q=2^{2}$,

$$
\begin{aligned}
E(G)= & \left\{\left(e_{0}, e_{1}, e_{2}, e_{3}, e_{4}\right),\left(e_{0}, 0,0,0,0\right),\left(0, e_{1}, 0,0,0\right),\left(0,0, e_{2}, 0,0\right)\right. \\
& \left.\left(0,0,0, e_{3}, 0\right),\left(0,0,0,0, e_{4}\right)\right\}
\end{aligned}
$$

where $e_{i} \in\left\{1=01, \alpha=10, \alpha^{2}=11\right\}$. A code locating $E(G)$ does not guarantee error correction since for two errors $e^{(1)}=(1,1,1,1,1), e^{(2)}=(1,1, \alpha, \alpha, \alpha)$ there is no pair $e^{(3)}, e^{(4)}$ with different support such that $e^{(1)}+e^{(2)}=e^{(3)}+e^{(4)}=$ $\left(0,0, \alpha^{2}, \alpha^{2}, \alpha^{2}\right)$ (note that $\left.\alpha^{2}+\alpha+1=0\right)$.

Using the above arguments one can see that any code over $Z_{q}$ locating up to $l$ independent errors $(E(G)=\{e \mid 0<\|e\| \leq 2 l\}$ ) can also correct $l$ errors. The same is also true for codes locating burst errors.

Let us now consider the case when at most $l$ components in $y=\left(y_{0}, \ldots, y_{n-1}\right)$ may be distorted $(E=\{e \mid 0<\|e\| \leq l\})$. In this case $H$ can be taken as the check matrix of the $q$-ary Reed-Solomon code of length $n[5]$

$$
H=\left[\begin{array}{lllll}
1 & 1 & 1 & \ldots & 1  \tag{34}\\
1 & \alpha & \alpha^{2} & \ldots & \alpha^{n-1} \\
1 & \alpha^{2} & \alpha^{4} & \ldots & \alpha^{2(n-1)} \\
& & \ddots & & \\
& & \alpha^{r-1} & \alpha^{2(r-1)} & \ldots
\end{array}\right]
$$

where $\alpha$ is primitive in $Z_{q}, n \leq q-1$ and $r=2 l$. For this matrix any $r$ columns are linearly independent over $Z_{q}$. Computing $Z=H y$, where $H$ is defined by (34), requires $n$ clocks and $r$ LFSRs with parallel input. An error locating procedure for this case identifies supp $(e)$ for a given $H e$. This procedure is based on the Euclidean algorithm [12] and has a complexity $L=O(l m)+O\left(\log _{2} n\right)$. ( $L$ is the number of equivalent two-input gates, $q=2^{m}$.) For example, for $n=100, m=32$ and $l=5$ we have $L \simeq 28,000$ [12]. We note also that $H$ defined by (34) with $r=2 l$ can be used for locating of more than $l$ errors. It was shown in [13] that if $\|e\|=t>l$ then the fraction $w$ of localizable errors with $\|e\|=t, l<t<2 l$, is lowerbounded by

$$
\begin{equation*}
w \geq\left(1-q^{-1}\right)^{\binom{n}{t}-1} \sim e^{-\binom{n}{t} q^{-1}} . \tag{35}
\end{equation*}
$$

For example, if $t=5, r=6, n=100, q=2^{32}$ ( $m=32$ ), then $w=0.979$. Thus, by allowing a small fraction of errors not to be located, one can reduce substantially the required redundancy from $r=2 l$ to $r=l+1$.

Let us consider now the error-locating problem when the original system is the full $p$-ary tree of height $h\left(n=p^{h-1}\right)$ (the 4-ary full tree of height $h=3$ is presented in Fig., and the error set for this tree is given by (14)).

The following recursive procedure can be used for construction of $H=H^{h}$ for $p$-ary trees [16].
where

$$
H^{(2)}=\left[\begin{array}{ccccc}
1 & 1 & 1 & \ldots & 1  \tag{37}\\
1 & \alpha & \alpha^{2} & \ldots & \alpha^{p-1} \\
1 & 0 & 0 & \ldots & 0 \\
0 & 1 & 0 & \ldots & 0
\end{array}\right]_{4 \times p}
$$

$4 \leq p<q$, and $\alpha$ is primitive in $Z_{q}$. Thus, for any $p$-ary, $(4 \leq p<q)$ tree $r=3 h-2$. For the case of $p=3$ one can also use the above construction (36) with $H^{(2)}=I_{3}$ ( $I_{3}$ is the identity matrix of $3 \times 3$ ). Therefore, for the $p$-ary tree with $p=3, q>$ $p, r=3 h-3$.

For binary trees over $Z_{q}$ the following recursive construction can be used:

$$
H^{(h)}=\left[\begin{array}{cc}
H^{(h-1)} & H^{(h-1)}  \tag{38}\\
10 \ldots 0 & 00 \ldots 0 \\
00 \ldots 0 & 10 \ldots 0
\end{array}\right]
$$

where $H^{(2)}=I_{2}$. Thus, for the binary tree over $Z_{q}$ of height $h, r=2 h-2$. The complexity $L$ for the syndrome computing network implementing $H^{(h)} y$ in terms of numbers adders and multipliers in $Z_{q}$ is [16]:

$$
\begin{equation*}
L=\left(2\left(p^{h-1}-p\right)+h(p-1)\right) L_{\otimes}+((h-1)(p-1)) L_{\otimes} \tag{39}
\end{equation*}
$$

where $L_{\otimes}$ is the complexity of a multiplier that multiplies a field element from $Z_{q}$ by a fixed element from the same field. This network for $h=3$ is represented in Fig.

The error locating procedure for tree errors is very simple. Let us denote

$$
S=H^{(h)} y=\left[\begin{array}{l}
S^{h-1}  \tag{40}\\
S_{1}^{h} \\
S_{2}^{h} \\
S_{3}^{h}
\end{array}\right]
$$

where $S^{h-1}$ are syndromes due to the $\left[H^{(h-1)} H^{(h-1)} \ldots H^{(h-1)}\right]$ part of $H^{(h)}$ (see (36)) and $S_{1}^{h}, S_{2}^{h}, S_{3}^{h}$ are syndromes for the last three rows of the parity check matrix $H^{(h)}$. Let $S^{1}$ denote the syndrome for the all 1 row. The location algorithm to find a faulty vertex is described as follows:

1. If $S_{i}=0, i=1,2, \ldots, 3 h-2$ : no error, end.
2. Let $j=h$
3. If both $S_{2}^{j} \neq 0$ and $S_{3}^{j} \neq 0$ : error location is the root of the tree of height j , end.
4. For $j>2$, if either $S_{2}^{j}=0$ or $S_{3}^{j}=0$ : error location in the subtree $k, 0 \leq$ $k \leq p-1$, where $\alpha^{k}=S_{1}^{j} / S_{2}^{j-1}$; for $j=2$, if either $S_{2}^{2}=0$ or $S_{2}^{3}=0$ : error location is in vertex (leaf) $k, 0 \leq k \leq p-1$, where $\alpha^{k}=S_{1}^{2} / S_{2}^{1}$.


Figure 4: Network for Computing $S=H^{(3)} y$
5. Repeat step 3 and 4 for the tree of height $j=j-1$.
6. Find.

The transform matrix $H_{3}$ for the 4 -ary tree of height $h=3$ is

$$
H^{(3)}=\left[\begin{array}{cccccccccccccccc}
1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1 & 1  \tag{41}\\
1 & \alpha & \alpha^{2} & \alpha^{3} & 1 & \alpha & \alpha^{2} & \alpha^{3} & 1 & \alpha & \alpha^{2} & \alpha^{3} & 1 & \alpha & \alpha^{2} & \alpha^{3} \\
1 & 0 & 0 & 0 & 1 & 0 & 0 & 0 & 1 & 0 & 0 & 0 & 1 & 0 & 0 & 0 \\
0 & 1 & 0 & 0 & 0 & 1 & 0 & 0 & 0 & 1 & 0 & 0 & 0 & 1 & 0 & 0 \\
1 & 1 & 1 & 1 & \alpha & \alpha & \alpha & \alpha & \alpha^{2} & \alpha^{2} & \alpha^{2} & \alpha^{2} & \alpha^{3} & \alpha^{3} & \alpha^{3} & \alpha^{3} \\
1 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 \\
0 & 0 & 0 & 0 & 1 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0
\end{array}\right]
$$

Suppose that a root of a subtree 1 (see Fig.) is faulty, $q=8, \alpha^{3}+\alpha+1=0$ and

$$
\begin{equation*}
e=\left(0,0,0,0, \alpha, \alpha, 1, \alpha^{3}, 0,0,0,0,0,0,0,0\right) \tag{42}
\end{equation*}
$$

Then

$$
\begin{equation*}
S=H^{(3)} e=\left(\alpha, \alpha^{5}, \alpha, \alpha, \alpha^{2}, 0, \alpha\right) \tag{43}
\end{equation*}
$$

This yields $S_{2}^{3}=0$, therefore the error is in the subtree 1 since $S_{1}^{3} / S_{2}^{3}=\alpha^{2} / \alpha=$ $\alpha, i=1$. Since $S_{2}^{2} \neq 0$ and $S_{2}^{3} \neq 0$, error is in the root of subtree 1 of height 2.

We note that the number, $r$, of rows in $H^{(h)}$ for $p$-ary trees of height $h$ can be drastically decreased (from $r=3 h-2$ to $r=h$ ) if we allow a small probability of misdiagnosis. In this case one can take [16]

$$
H^{(h)}=\left[\begin{array}{llll}
H^{(h-1)} & H^{(h-1)} & \ldots & H^{(h-1)}  \tag{44}\\
11 \ldots 1 & \alpha \alpha \ldots \alpha & \ldots & \alpha^{p-1} \alpha^{p-1} \ldots \alpha^{p-1}
\end{array}\right]
$$

where

$$
H^{(2)}=\left[\begin{array}{lllll}
1 & 1 & 1 & \ldots & 1 \\
1 & \alpha & \alpha^{2} & \ldots & \alpha^{n-1}
\end{array}\right], n=p<q .
$$

The number of rows in $H^{(h)}$, defined by (44), is equal to $h$. The location procedure in this case is very simple, and the probability of correct diagnosis for this procedure can be estimated as [16]

$$
\begin{equation*}
w==1-\left(1-p q^{-1}\right)^{h-1} \tag{45}
\end{equation*}
$$

which is small for large $q$.

## 4. Hard Decision Diagnosis.

The hard decision diagnosis problem can be formulated in the following way. For a given $E(G) \subseteq Z_{q}^{n}$ construct a binary matrix $H$ with minimal number of rows such that for any $\mathrm{e}^{(1)}, e^{(2)} \in E(G)$ with

$$
\begin{align*}
& \quad \operatorname{supp}\left(e^{(1)}\right) \neq \operatorname{supp}\left(e^{(2)}\right), \quad \operatorname{supp}\left(H e^{(1)}\right) \neq \operatorname{supp}\left(H e^{(2)}\right) \\
& \text { where } \operatorname{supp}\left(Z=Z_{0}, \ldots, Z_{r-1}\right)=\left(\operatorname{supp}\left(Z_{0}\right), \ldots, \operatorname{supp}\left(Z_{r-1}\right)\right) . \tag{46}
\end{align*}
$$

The hard decision approach allows identification of errors $e$ by analyzing supports of their syndromes $S=H e$. Magnitudes of distortions in components of a syndrome are not important for the hard decision diagnosis. The identification of locations of errors is possible if there is a one-to-one mapping

$$
E(G) \leftrightarrow\{\operatorname{supp}(H e) \mid e \in E(G)\}
$$

In general, this approach requires more rows in $H$ (more observation points for the compressed response $Z=H y$ ) but the decoding procedure is very simple and has a straightforward hardware implementation.

Let $H \otimes \operatorname{supp}(e)$ denote the Boolean multiplication of an $(r \times n)$ binary matrix $H$ by an $n$-bit binary vector $\operatorname{supp}(e)=\left(\sup p\left(e_{0}\right), \ldots, \sup p\left(e_{n-1}\right)\right)$ with the addition being replaced by logical summation (OR). Then with probability $1-q^{-1}$ if

$$
\begin{equation*}
H \otimes \operatorname{supp}\left(e^{(1)}\right) \neq H \otimes \operatorname{supp}\left(e^{(2)}\right) \tag{47}
\end{equation*}
$$

then

$$
H e^{(1)} \neq H e^{(1)} ; e^{(1)}, e^{(2)} \in E(G) \subseteq Z_{q}^{n}
$$

and

$$
\operatorname{supp}\left(e^{(1)}\right) \neq \operatorname{supp}\left(e^{(2)}\right)
$$

Let us consider now the hard decision diagnosis problem for the case of $l$ independent errors ( $E=\{e \mid 0<\|e\| \leq l\}$ ). We note that in this case any check matrix of an l-th order binary superimposed code $[24,25,26,27]$ can be chosen as the transform matrix $H$.

A binary superimposed code of order $l$ consists of a set of codewords such that componentwise Boolean sum (OR) of any $l$ codewords differs from every other componentwise sum of $l$ or fewer codewords. Thus, in view of (47), any check matrix of an $l-t h$ order linear superimposed code can be chosen as a hard decision diagnostic matrix $H$. Since there are $|E|=\sum_{i=0}^{l}\binom{n}{i}$ different locations of $l$ errors, we have the following lower bound on the minimal number $r=r(n, l)$ of the required spectral coefficients (rows in $H$ )

$$
\begin{equation*}
r(n, l) \geq\left\lceil\log _{2} \sum_{i=0}^{i}\binom{n}{l}\right\rceil \tag{48}
\end{equation*}
$$

For the case of single errors ( $l=\|e\|=1$ ), one can take as $H$ any binary matrix with different nonzero columns. Thus

$$
\begin{equation*}
r(n, l)=\left\lceil\log _{2}(n+1)\right\rceil \tag{49}
\end{equation*}
$$

The case of multiple errors ( $l>1$ ) is not as simple and it is difficult even to estimate $r=r(n, l)$. Several good constructions of check matrices for linear superimposed codes can be found in [24, 25, 26].

A hardware implementation of the hard decision diagnostic algorithms for $l=$ $1, n=100, q=2^{32}$ requires about 10,000 equivalent two-input gates [27].

Let us consider now a general case of hard decision diagnosis, when the error set $\mathrm{E}(G)$ is defined by the topology $G$ of the system. Let $N$ be the number of processing elements in the systems (nodes in $G$ ) and $d$ is the length (number of nodes) of the longest path in $G$. Then we have the following attainable bounds on minimal number of rows in $H$

$$
\begin{equation*}
\max \left(\left\lceil\log _{2}(N+1)\right\rceil, d\right) \leq r \leq n \tag{50}
\end{equation*}
$$

These bounds can be improved if we have additional information about the topology of the system.

Let $N(j)$ be the number of paths of length at least $j$ and $M(j)$ be the number of paths of length at least $j$ which do not have any endpoints in common. The following two lower bounds on $r$ have been proven in [28, 29]:

$$
\begin{gather*}
\sum_{i=1}^{r-j+1}\binom{r}{i} \geq N(j)  \tag{51}\\
\sum_{i=1}^{\left\lceil(r-j) 2^{-1}\right\rceil}\binom{r}{i}+\sum_{i=\left\lceil(r+j) 2^{-1}\right\rceil}^{r}\binom{r}{i} \geq M(j) . \tag{52}
\end{gather*}
$$

Lower bounds (51), (52) are valid for all values of $j=1,2, \ldots, d$.
For the $p$-ary full tree of height $h$ we have $d=h, n=p^{h-1}, N=\frac{p^{h}-1}{p-1}$ and $N(d)=p^{d-1}$. Thus, by (50), (51) we have the following lower bounds for the minimal

| d | 2 | 3 | 4 | 5 | 6 | 7 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{r}(d)$ | 2 | 4 | 5 | 6 | 8 | $9-10$ |


| d | 8 | 9 | 10 | 11 | 12 |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{r}(d)$ | $10-11$ | 12 | $13-14$ | $14-16$ | $16-17$ |

Table 1: Minimal Numbers of Spectral Coefficients Required for Hard Decision Diagnosis of Binary Trees
number $r=r(d)$ of spectral coefficients required for hard diagnosis of $p$-ary trees of height $h=d$.

$$
\begin{equation*}
r(d) \geq\left\lceil\log _{2}\left(\frac{p^{d-1}-1}{p-1}+1\right)\right\rceil \tag{53}
\end{equation*}
$$

and

$$
\begin{equation*}
\sum_{i=1}^{r(d)-d+1}\binom{r(d)}{i} \geq p^{d-1} \tag{54}
\end{equation*}
$$

Solving (54) for $d \gg 1$ we have asymptotically

$$
r(d)> \begin{cases}1.29(d-1), & p=2  \tag{55}\\ 1.64(d-1), & p=3 \\ \left(\log _{2} p\right)(d-1), & p \geq 4\end{cases}
$$

We note, that for $p \geq 4$ and $d \gg 1$ (53) gives better lower bounds than (55). The best known upper bounds on $r$ for binary trees [29] are given by

$$
r(d) \leq \begin{cases}1.5(d-1), & d=4 r+1  \tag{56}\\ \lceil 1.5(d-1)\rceil+1, & \text { otherwise }\end{cases}
$$

Values of $r(d)$ for binary trees with $N<2^{12}$ are given in the Table 1:
Optimal or near optimal constructions for $\left(r(d) \times p^{d-1}\right)$ transform matrices $H$ for $p$-ary trees, together with lower and upper bounds for $r(d)$ for different $p>2$ and $N=\frac{p^{d}-1}{p-1}<5,000$ can be found in [28,29]. The gap between bounds is small.

Constructions for optimal or near optimal transforms for hard diagnosis for two dimensional meshes and multidimensional cube topologies can be found in [29].

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